

74VHC02

Quad 2-Input NOR Gate

General Description

The VHC02 is an advanced high-speed CMOS 2-Input NOR Gate fabricated with silicon gate CMOS technology. It achieves the high-speed operation similar to equivalent Bipolar Schottky TTL while maintaining the CMOS low power dissipation. The internal circuit is composed of 3 stages, including buffer output, which provide high noise immunity and stable output. An input protection circuit insures that 0V to 7V can be applied to the input pins without regard to the supply voltage. This device can be used to interface 5V to 3V systems and two supply systems such

as battery backup. This circuit prevents device destruction due to mismatched supply and input voltages.

Features

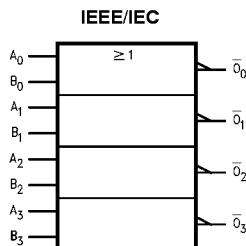
- High Speed: $t_{PD} = 3.6$ ns (typ) at $V_{CC} = 5V$
- Low power dissipation: $I_{CC} = 2 \mu A$ (max) at $T_A = 25^\circ C$
- High noise immunity: $V_{NIH} = V_{NIL} = 28\% V_{CC}$ (min)
- Power down protection is provided on all inputs
- Low noise: $V_{OLP} = 0.8V$ (max)
- Pin and function compatible with 74HC02

Ordering Code:

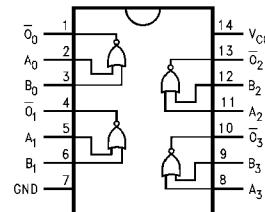
Order Number	Package Number	Package Description
74VHC02M	M14A	14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-120, 0.150" Narrow
74VHC02SJ	M14D	14-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
74VHC02MTC	MTC14	14-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide
74VHC02N	N14A	14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide

Surface mount packages are also available on Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Logic Symbol



Connection Diagram



Pin Descriptions

Pin Names	Description
A_n, B_n \bar{O}_n	Inputs Outputs

Truth Table

A	B	\bar{O}
L	L	H
L	H	L
H	L	L
H	H	L

Absolute Maximum Ratings(Note 1)

Supply Voltage (V_{CC})	-0.5V to +7.0V
DC Input Voltage (V_{IN})	-0.5V to +7.0V
DC Output Voltage (V_{OUT})	-0.5V to $V_{CC} + 0.5V$
Input Diode Current (I_{IK})	-20 mA
Output Diode Current (I_{OK})	± 20 mA
DC Output Current (I_{OUT})	± 25 mA
DC V_{CC}/GND Current (I_{CC})	± 50 mA
Storage Temperature (T_{STG})	-65°C to +150°C
Lead Temperature (T_L) (Soldering, 10 seconds)	260°C

Recommended Operating Conditions(Note 2)

Supply Voltage (V_{CC})	2.0V to +5.5V
Input Voltage (V_{IN})	0V to +5.5V
Output Voltage (V_{OUT})	0V to V_{CC}
Operating Temperature (T_{OPR})	-40°C to +85°C
Input Rise and Fall Time (t_r, t_f)	
$V_{CC} = 3.3V \pm 0.3V$	0 ~ 100 ns/V
$V_{CC} = 5.0V \pm 0.5V$	0 ~ 20 ns/V

Note 1: Absolute Maximum Ratings are values beyond which the device may be damaged or have its useful life impaired. The databook specifications should be met, without exception, to ensure that the system design is reliable over its power supply, temperature, and output/input loading variables. Fairchild does not recommend operation outside databook specifications.

Note 2: Unused inputs must be held HIGH or LOW. They may not float.

DC Electrical Characteristics

Symbol	Parameter	V_{CC} (V)	$T_A = 25^\circ C$			Units	Conditions
			Min	Typ	Max		
V_{IH}	HIGH Level Input Voltage	2.0 3.0 ~ 5.5	1.50 0.7 V_{CC}		1.50 0.7 V_{CC}	V	
V_{IL}	LOW Level Input Voltage	2.0 3.0 ~ 5.5		0.50 0.3 V_{CC}	0.50 0.3 V_{CC}	V	
V_{OH}	HIGH Level Output Voltage	2.0 3.0 4.5	1.9 2.9 4.4	2.0 3.0 4.5	1.9 2.9 4.4	V	$V_{IN} = V_{IH}$ or V_{IL} $I_{OH} = -50 \mu A$
		3.0	2.58		2.48	V	$I_{OH} = -4 mA$
		4.5	3.94		3.80		$I_{OH} = -8 mA$
	LOW Level Output Voltage	2.0 3.0 4.5	0.0 0.0 0.0	0.1 0.1 0.1	0.1 0.1 0.1	V	$V_{IN} = V_{IH}$ or V_{IL} $I_{OL} = 50 \mu A$
		3.0		0.36	0.44	V	$I_{OL} = 4 mA$
		4.5		0.36	0.44		$I_{OL} = 8 mA$
I_{IN}	Input Leakage Current	0 ~ 5.5		± 0.1	± 1.0	μA	$V_{IN} = 5.5V$ or GND
I_{CC}	Quiescent Supply Current	5.5		2.0	20.0	μA	$V_{IN} = V_{CC}$ or GND

Noise Characteristics

Symbol	Parameter	V_{CC} (V)	$T_A = 25^\circ C$		Units	Conditions
			Typ	Limits		
V_{OLP} (Note 3)	Quiet Output Maximum Dynamic V_{OL}	5.0	0.3	0.8	V	$C_L = 50 pF$
V_{OLV} (Note 3)	Quiet Output Minimum Dynamic V_{OL}	5.0	-0.3	-0.8	V	$C_L = 50 pF$
V_{IHD} (Note 3)	Minimum HIGH Level Dynamic Input Voltage	5.0		3.5	V	$C_L = 50 pF$
V_{ILD} (Note 3)	Maximum LOW Level Dynamic Input Voltage	5.0		1.5	V	$C_L = 50 pF$

Note 3: Parameter guaranteed by design.

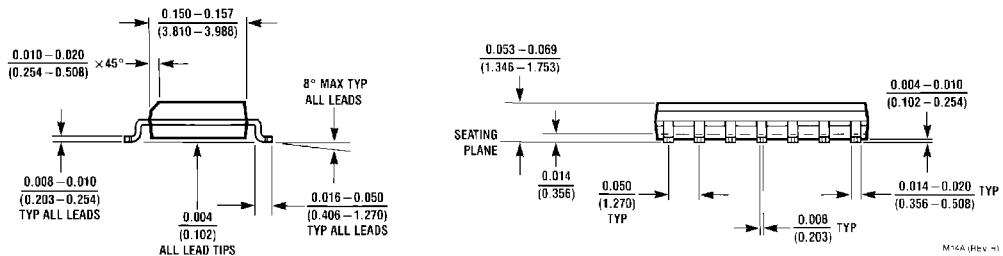
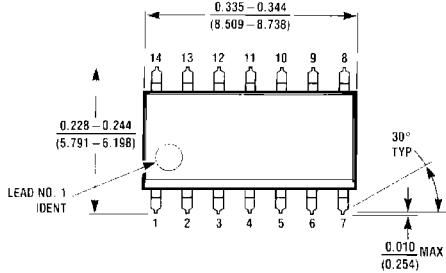
AC Electrical Characteristics

Symbol	Parameter	V _{CC} (V)	T _A = 25°C			T _A = -40°C to +85°C		Units	Conditions
			Min	Typ	Max	Min	Max		
t _{PHL}	Propagation Delay	3.3 ± 0.3		5.6	7.9	1.0	9.5	ns	C _L = 15 pF
				8.1	11.4	1.0	13.0		C _L = 50 pF
		5.0 ± 0.5		3.6	5.5	1.0	6.5	ns	C _L = 15 pF
				5.1	7.5	1.0	8.5		C _L = 50 pF
C _{IN}	Input Capacitance			4	10		10	pF	V _{CC} = Open
C _{PD}	Power Dissipation Capacitance			15				pF	(Note 4)

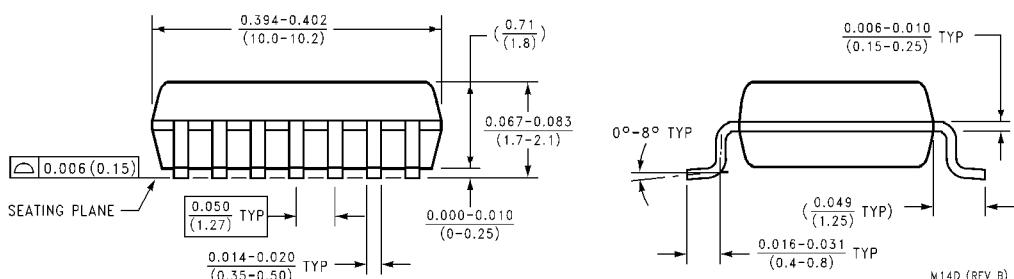
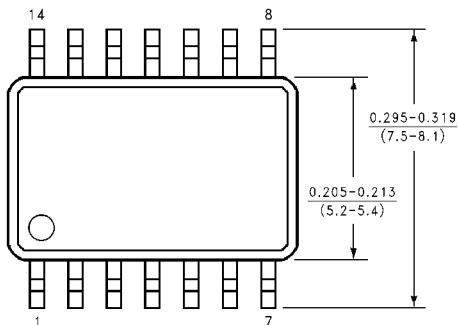
Note 4: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load. Average operating current can be obtained by the equation: I_{CC} (opr.) = C_{PD} * V_{CC} * f_{IN} + I_{CC}/4 (per gate).

74VHC02

Physical Dimensions inches (millimeters) unless otherwise noted

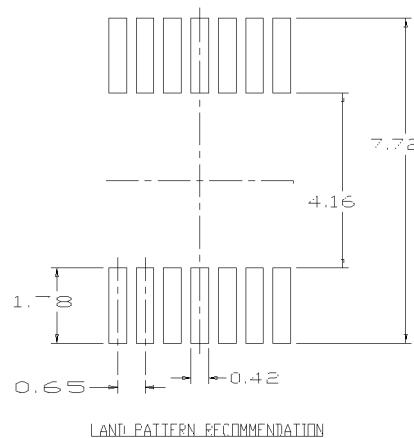
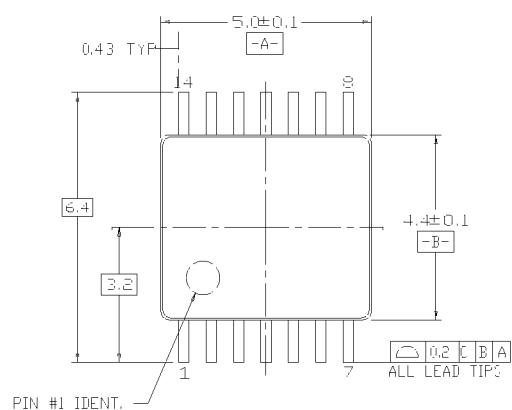


14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-120, 0.150" Narrow Package Number M14A

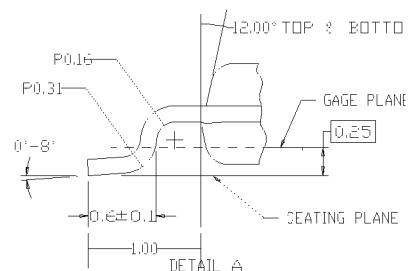
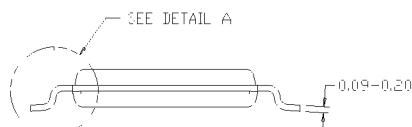
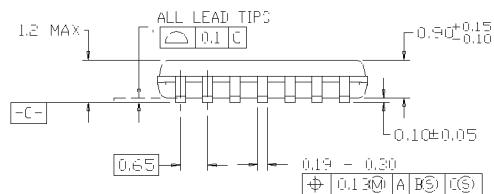


14-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide Package Number M14D

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



LAND PATTERN RECOMMENDATION



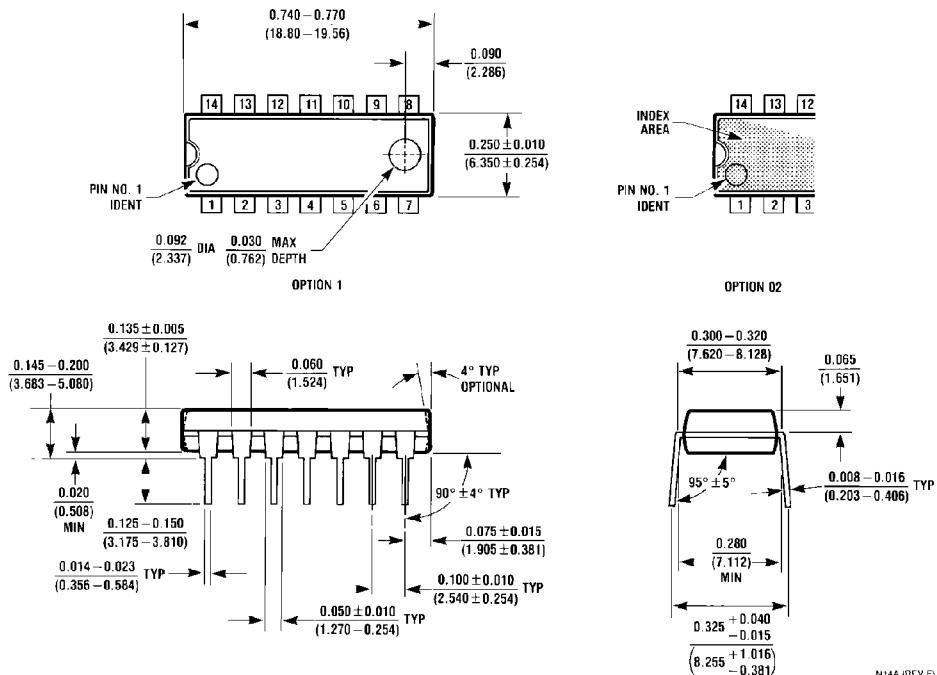
NOTES:

- CONFORMS TO JEDEC REGISTRATION MO-153 VARIATION AB, REF NOTE 6, DATED 7/93
- DIMENSIONS ARE IN MILLIMETERS
- DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS

**14-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide
Package MTC14**

74VHC02 Quad 2-Input NOR Gate

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide
Package Number N14A

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